Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/535,257	OKAMOTO ET AL.	
Examiner	Art Unit	
Trinh T. Nguyen	3644	

	SEARCHED					
Class	Subclass	Date	Examiner			
119	264,227, 259	4/28/2006	TTN			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
inventor name search was performed	4/28/2006	TTN